

Thermal activation in Permalloy nanorectangles at room temperature

E. Martinez^{a,*}, L. Lopez-Diaz^a, L. Torres^a, C.J. Garcia-Cervera^b

^a*Departamento de Física Aplicada, Universidad de Salamanca, Plaza de la Merced s/n, E-37001, Salamanca, Spain*

^b*Mathematics Department, University of California, Santa Barbara, CA 93106, USA*

Abstract

The effect of thermal activation in planar Permalloy nanorectangles of thickness $L_z = 2.5$ nm, width $L_y = 20$ nm and different in plane aspect ratios ($r = L_x/L_y$) has been analyzed assuming uniform magnetization in the sample at room temperature. The relaxation times were computed by integrating the Langevin equation in presence of external fields that reduce the energy barrier separating the two energy minima. From these data we obtain the pre-exponential factor in the Arrhenius formula for each aspect ratio. That allows us to estimate the relaxation time in the absence of external field. A minimum aspect ratio of $r = 3.25$ is required for a lifetime larger than 100 years, which is a commonly accepted stability criterion.

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1. Introduction

A magnetic random access memory (MRAM) is an array of magnetic tunnel junctions (MTJs), each one comprising a soft magnetic element (free layer) and a hard element (pinned layer) separated by a thin insulating layer [1]. On each MTJ, the information is written by passing electrical currents through two orthogonal metallized tracks (word and bit lines), which induce a magnetic field in the free layer to reverse its magnetization. In the reading processes, the state of the free layer can be determined by magnetoresistance measurements of the MTJ: if both free and pinned layers are magnetized in the same (opposite) direction, the MTJ has low resistance (high resistance).

The shape and dimensions of the free layer are chosen in order to achieve single domain bi-stable behavior. The two equilibrium states of opposite magnetization are separated by an energy barrier ΔE , which is due to shape and/or magnetocrystalline anisotropy. This double-well structure of the energy is the archetype of the hysteretic behavior. In the deterministic case ($T = 0$ K), the system can only jump from one state to the other if an external field is applied.

However, at finite temperature ($T \neq 0$ K) the system can escape from one state to the other by thermal activation over the barrier ΔE even if the external field is null. Superparamagnetism concerns the loss of magnetic stability as a result of thermal fluctuations that occur when free layers are made too small [2]. In order to achieve higher density storage, the free layer dimensions must be reduced. However, superparamagnetism becomes increasingly important as magnetic particles become small, and it is thought to be the limiting factor for increasing storage densities in magnetic data systems.

It is a requirement for data storage that thermally activated hopping from one well to the other must be improbable over very long periods of time. According to the Arrhenius–Neel model, the relaxation time τ_R is given by

$$\frac{1}{\tau_R} = \frac{dp}{dt} = \frac{1}{\tau_0} \exp\left(-\frac{\Delta E}{K_B T}\right), \quad (1)$$

which describes the probability per unit time dp/dt , of hopping from one well to the other over an energy barrier ΔE . T is the temperature, K_B is the Boltzmann constant, and, τ_0 is a constant related to the gyromagnetic precession period of the magnetic system.

*Corresponding author. Fax: +34 923 294584.

E-mail address: a2577@usal.es (E. Martinez).

At low temperature and zero external field ($H_{\text{ext}} = 0$), the energy barrier between the two states of opposite magnetization is too much high to observe an escape process by numeric simulations, where typical measures are limited to a few microseconds. However, the energy barrier can be reduced by applying a magnetic field ($H_{\text{ext}} \neq 0$) in the opposite direction to that of the particle's magnetization. When the applied field is close enough to the switching field at zero temperature (H_{SW}), thermal fluctuations are sufficiently strong to allow the system to overcome the barrier, and therefore the magnetization is reversed.

From Arrhenius–Neel model (1), the relaxation time τ_R at a given temperature can be determined if the energy barrier ΔE and the pre-exponential factor τ_0 are known. In present work, we have measured the relaxation time τ_R when an external field is applied to reduce the energy barrier at room temperature by solving the Langevin dynamics. From these values, an estimation of the pre-exponential factor τ_0 can be obtained by fitting the numeric results to the Arrhenius–Neel formula (1). Once τ_0 is known for each sample, the relaxation time without external field can be inferred in order to compare it with the stability criterion of one hundred years.

2. Model and numerical details

Let us consider each free layer in a MRAM to be Permalloy (saturation magnetization $M_s = 8.6 \times 10^5$ A/m, $K_u = 0$, and damping parameter $\alpha = 0.02$) prisms $L_x \times 20 \text{ nm} \times 2.5 \text{ nm}$. We have analyzed samples with L_x between 40 nm ($r = L_x/L_y = 2$) and 120 nm ($r = 6$). Inter-layer coupling from the pinned layer, and magnetocrystalline anisotropy ($K = 0$) are ignored.

Deterministic ($T = 0 \text{ K}$) hysteresis loops have been calculated assuming that the particle is uniformly magnetized by solving the Landau–Lifshitz–Gilbert equation for each external field value. We considered that the equilibrium state is reached if the torque between the magnetization \mathbf{m} and the effective field \mathbf{h}_{eff} (external field and magnetostatic field) is $|\mathbf{m} \times \mathbf{h}_{\text{eff}}| < 10^{-6}$. Several in-plane fields were evaluated forming different angles (φ_H) with $x > 0$ axis. The hysteresis loops along the external field directions are displayed in Fig. 1 for a sample with $r = 4$.

From the simulations we observe that the out-of-plane magnetization component (m_z) is always negligible ($m_z \approx 10^{-5}$), and therefore a 2D model is justified. Within this approximation the energy of the system can be written as [3]

$$E = E_{\text{dmg}} + E_{\text{ext}} = K_{\text{sh}} V \sin^2 \varphi_M - \mu_0 M_s V H_{\text{ext}} \cos(\varphi_M - \varphi_H), \quad (2)$$

where V is the volume of the particle, H_{ext} is the external field, and φ_M and φ_H are the angles of magnetization and external field measured from the easy axis of magnetization (x -axis). In this case, the shape anisotropy constant K_{sh} is

given by

$$K_{\text{sh}} = \frac{1}{2} \mu_0 M_s^2 (N_y - N_x), \quad (3)$$

where N_x y N_y are the demagnetizing factors [4]. The energy (2) has two minima separated by an energy barrier. The height of the barrier is related to the modulus of K_{sh} which increases with the in-plane aspect ratio $r = L_x/L_y$. According to the Stoner–Wohlfarth model, the angular dependence of the switching field H_{SW}^0 (defined as the field at which the energy loses its biestable character, $\partial E / \partial \varphi_M = \partial^2 E / \partial \varphi_M^2 = 0$) is given by [3]

$$H_{\text{SW}}^0 = \frac{2K_{\text{sh}}}{\mu_0 M_s} (\sin^{2/3} \varphi_H + \cos^{2/3} \varphi_H)^{-3/2}. \quad (4)$$

The switching fields obtained from the simulations (Fig. 1) agree with those obtained from Eqs. (4) and (3) with a relative

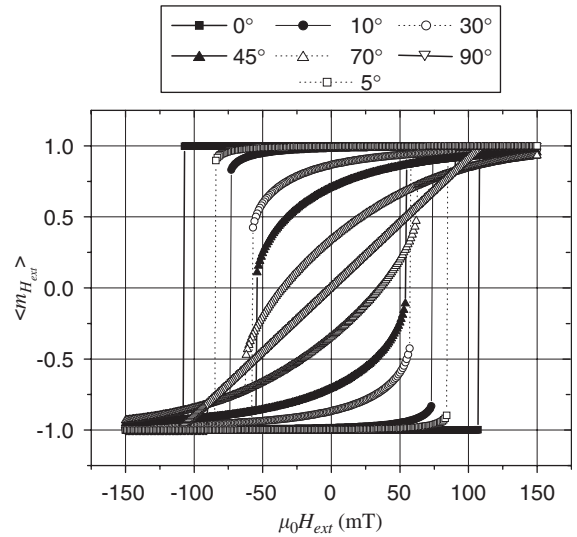


Fig. 1. Hysteresis loops for a prism of 80 nm × 20 nm × 2.5 nm ($r = 4$). $\langle m_H \rangle = \cos(\varphi_M - \varphi_H)$ represents the magnetization along the external field.

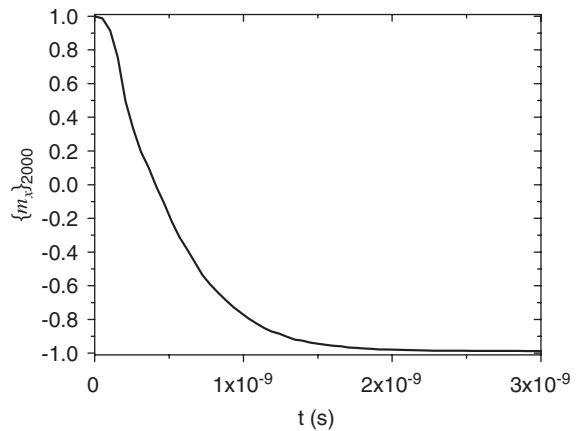


Fig. 2. Averaged trajectory over 2000 stochastic realization of the magnetization parallel to the easy axis. The specific sample (40 nm × 20 nm × 2.5 nm, $r = 2$) is initially magnetized along $x > 0$, and the external field is 50 mT at 185° (around 4.5 mT smaller than the corresponding coercive field).

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